

IGBT4 High Power Chip

FEATURES:

- 1200V Trench + Field Stop technology
- Iow V_{CEsat}
- soft turn off
- positive temperature coefficient
- easy paralleling

This chip is used for:

• medium / high power modules

• medium / high power drives



Chip Type	V _{CE}	I Cn	Die Size	Package
IGC142T120T6RH	1200V	150A	11.31 x 12.56 mm ²	sawn on foil

Applications:

MECHANICAL PARAMETER

Raster size	11.31 x 12.56				
Emitter pad size (incl. gate pad)	11.04 x 9.80	mm ²			
Gate pad size	1.31 x 0.81				
Area total / active	142.1 / 113.1				
Thickness	140				
Wafer size	150	mm			
Flat position	90	grd			
Max.possible chips per wafer	94				
Passivation frontside	Photoimide				
Pad metal	3200 nm AlSiCu				
Backside metal	Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	Electrically conductive glue or solder				
Wire bond	Al, <500µm				
Reject ink dot size	Ø 0.65mm ; max 1.2mm				
Recommended storage environment	Store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



MAXIMUM RATINGS

Parameter	Symbol	Value	Unit	
Collector-Emitter voltage , Tj=25 °C	V _{CE}	1200	V	
DC collector current, limited by T _{jmax}	I _C	1)	А	
Pulsed collector current, t_p limited by T_{jmax}	I _{cpuls}	450	А	
Gate - Emitter voltage	V _{GE}	±20	V	
Operating junction temperature	Tj	-40 +175	°C	
Short circuit data ² V \approx = 15V, V \propto = 800V, Tvj = 150°C	tp	10	μs	
Reverse bias safe operating area ²⁾ (RBSOA)	$I_{C max}$ = 300A, $V_{CE max}$ = 1200V, Tvj max= 150°C			

¹⁾ depending on thermal properties of assembly

²⁾ not subject to production test - verified by design/characterization

STATIC CHARACTERISTICS (tested on wafer), $\mathit{T_{j}}\text{=}25~^{\circ}\text{C}$

Parameter	Symbol	Conditions	Value			Unit
	Cymbol	Conditions	min.	typ.	max.	•
Collector-Emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V , I _C = 6 mA	1200			
Collector-Emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =150A	1.5	1.7	2.0	V
Gate-Emitter threshold voltage	V _{GE(th)}	I_{C} =6mA , V_{GE} = V_{CE}	5.0	5.8	6.5	
Zero gate voltage collector current	I _{CES}	V_{CE} =1200V , V_{GE} =0V			20	μA
Gate-Emitter leakage current	I _{GES}	$V_{CE}=0V$, $V_{GE}=20V$			600	nA
Integrated gate resistor	R _{Gint}			5		Ω

ELECTRICAL CHARACTERISTICS (not subject to production test - verified by design/characterization)

Parameter	Symbol	Conditions	Value			Unit
	Symbol	Conditions	min.	typ.	max.	Onit
Input capacitance	Ciss	V _{CE} =25V,		9300		
Output capacitance	Coss	$V_{GE} = 0 V$,		580		рF
Reverse transfer capacitance	C _{rss}	f=1MHz		510		



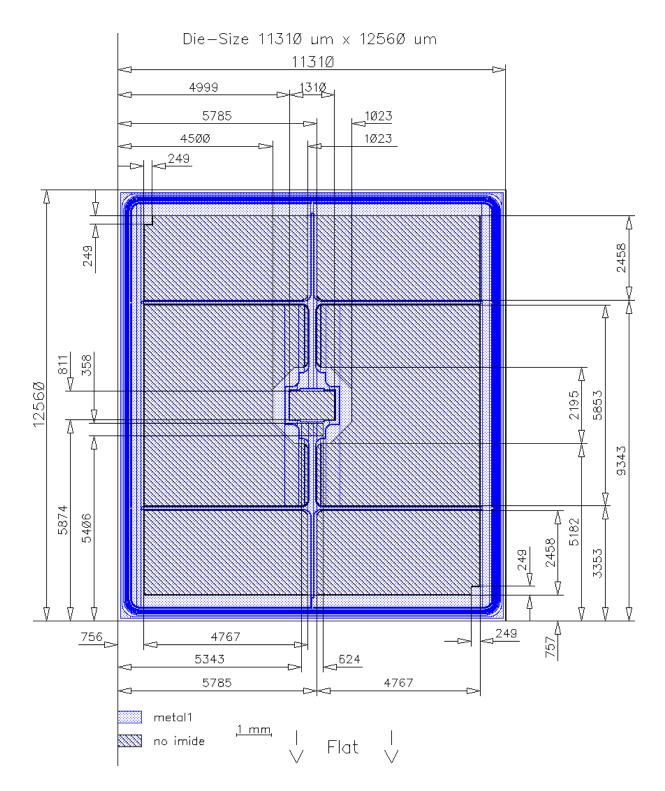
SWITCHING CHARACTERISTICS inductive load (not subject to production test - verified by design /characterization)

Parameter	Symbol	Conditions ¹⁾	Value			Unit
raianetei	Symbol		min.	typ.	max.	onic
Turn-on delay time	t _{d(on)}	$T_j = 125^{\circ}C$ $V_{CC} = 600V$, $I_C = 150A$, $V_{GE} = -15/15V$,		tbd		
Rise time	<i>t</i> r			tbd		
Turn-off delay time	t _{d(off)}			tbd		ns
Fall time	t _f	R _G =Ω		tbd		

 $^{1)}\ensuremath{\text{values}}$ also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING



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FURTHER ELECTRICAL CHARACTERISTICS

This chip data sheet refers to the device data sheet	tbd	

DESCRIPTION

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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